

Search Notes

Application/Control No.

10/757,204

Examiner

Sang Nguyen

Applicant(s)/Patent under
R examination

KE ET AL.

Art Unit

2877

SEARCHED

Class	Subclass	Date	Examiner
356	364-369	6/2/2006	SN
↕	630	↕	↕
↕	72-73		
250	559.28		
↕	559.29	↕	↕
↕	256	↕	↕
↕	225	6/2/2006	SN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/2/2006	SN